

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/735,916		GOETSCH ET AL.	
Examiner				Art Unit			
Phuong Huynh		1644					

ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
424	130.1	424	133.1	134.1	135.1	141.1	143.1		
INTERNATIONAL CLASSIFICATION				425	7.1	810			
C	0	7	K	16/28	530	387.1	387.3	381.22	
C	1	2	P	21/08				391.3	
A	6	1	K	39/395					
A	6	1	K	39/00					
G	0	1	N	33/53					
 Phuong Huynh 3/2/07 (Assistant Examiner) (Date)				 CHRISTINA CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1600 <small>(Primary Examiner)</small> 3/5/07				Total Claims Allowed: 17	
 <small>Legal Instruments Examiner</small> 5-3-07 (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. None

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
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25	25	3	55	85	115	145	175
26	26	4	56	86	116	146	176
27	27	5	57	87	117	147	177
28	28	6	58	88	118	148	178
29	29	7	59	89	119	149	179
2	30	8	60	90	120	150	210